## Search Notes



Application/Control No.		Applicant(s)/Patent Under Reexamination	
105419	06	FINCH ET AL.	
Examiı	ner	Art Unit	
Barker,	Matthew	3662	

SEARCHED							
Class	Subclass	Date	Examiner				
342	157.2,194,	12/21/2006	Hien Le				
342	163,159-164	8/9/2007	Hien Ly				
342	160	6/12/2008	MMB				

SEARCH NOTES					
Search Notes	Date	Examiner			
Inventor's name search	12/20/2006	Hien Ly			
NPL search	12/20/2006	Hien Ly			
Plus search	12/20/2006	Hien Ly			
Text search	12/20/2006	Hien ly			
NPL search (update)	8/8/2007	Hien ly			
Text search (update)	8/8/2007	Hien Ly			
342/104, 105, 109, 115, 194, 195, 161, 162, 164 - test search, see printoutx	6/12/2008	MMB			
EAST text search - see printout	6/13/2008	MMB			

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

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